



IEW

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re the Application of

Inventor: Sven SALZER et al. Group Art Unit: 2622
Appln. No.: 10/666,531 Examiner: M. Lee
Filed: September 22, 2003
For: METHOD AND VIDEO PROCESSING UNIT FOR PROCESSING A
VIDEO SIGNAL

CERTIFICATION UNDER 37 CFR §1.97(e)(1)

Assistant Commissioner of Patents
Washington, DC 20231

Dear Sir:

In fulfillment of 37 CFR 1.97(c)(1) and 1.97(e)(1), it is hereby certified that each item of information contained in the attached Information Disclosure Statement was first cited in any communication (see the attached copy of a Japanese Office Action dated August 29, 2006) from a foreign patent office in a counterpart foreign application not more than three months prior to the filing of this Information Disclosure Statement.

Respectfully submitted,

James E. Ledbetter
Registration No. 28,732

Date: October 24, 2006

JEL/jpf

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In re the Application of

Inventor: Sven SALZER et al. Group Art Unit: 2622

Appln. No.: 10/666,531 Examiner: M. Lee

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INFORMATION DISCLOSURE STATEMENT

Assistant Commissioner of Patents
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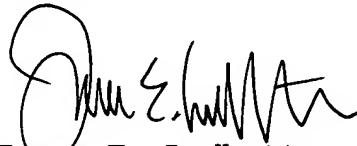
Dear Sir:

Pursuant to Rules 56 and 97(c), Applicants hereby call the attention of the Patent Office to the references listed on the attached Form PTO-1449. Attached is a Japanese Office Action dated August 29, 2006 with an English translation thereof. JP '913 cited therein was filed in the Information Disclosure Statement of September 22, 2003. JP '317 corresponds to EP '836. JP '251 corresponds to EP '375. JP '009 corresponds to US '319. JP '457 corresponds to '406. JP '183 corresponds to '350. JP '748 corresponds to '412.

Applicants present this art so that the Patent Office may, in the first instance, determine any relevancy thereof to the presently claimed invention, see Beckman Instruments, Inc. v. Chemtronics, Inc., 439 F.2d 1369, 1380, 165 USPQ 355, 364 (5th Cir.

1970). Also see Patent Office Rules 104 and 106. Applicants respectfully request that this art be expressly considered during the prosecution of this application and made of record herein and appear among the "References Cited" on any patent to issue herefrom.

Respectfully submitted,



James E. Ledbetter
Registration No. 28,732

Date: October 24, 2006

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FORM PTO-1449 U.S. Department of Commerce
(Rev. 4/92) Patent and Trademark Office

INFORMATION DISCLOSURE STATEMENT BY APPLICANT

(Use several sheets if necessary)

OCT 24 2006

ATTY. DOCKET NO.

L7725.03108

SERIAL NO.

10/666,531

APPLICANT

Sven SALZER, et al.

FILING DATE

September 22, 2003

GROUP

2622

U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER								DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE	
		6	7	8	8	3	1	9							
		6	8	8	5	4	0	6		9/2004	Matsumoto, et al.				
		6	8	8	5	4	0	6		4/2005	Yui, et al.				
		5	2	8	0	3	5	0		1/1994	DeHaan, et al.				
		6	1	4	4	4	1	2		11/2000	Hirano, et al.				

FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER								DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	YES	NO	
		1	0	1	3	1	7										
	2002	1	0	1	3	1	7			04/2002	JP						
		1	1	6	8	8	3	6		01/2002	EP						
		4	2	8	6	2	7	9		10/1992	JP			Abstract			
		5	1	7	6	2	5	1		7/1993	JP						
		0	5	1	2	3	7	5		11/1992	EP						
	2001	3	5	9	0	0	9			12/2001	JP						
	2002	1	7	1	4	5	7			6/2002	JP						
		4	2	5	7	1	8	3		9/1992	JP						
		1	0	1	2	6	7	4	8	5/1998	JP						
	2001	1	1	1	9	1	3			4/2001	JP			Abstract			
		1	0	1	7	4	0	1	5	6/1998	JP			Abstract			

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

Japanese Office Action dated August 29, 2006 with English translation.

EXAMINER

DATE CONSIDERED

EXAMINER: Initial if citation is considered, draw line through citation if not in conformance and not considered.
Include copy of this form with next communication to applicant.